# **Structural and dielectric properties of Sr2TiO4 from first principles**

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(Received 16 May 2003; published 21 November 2003)

We have investigated the structural and dielectric properties of  $Sr<sub>2</sub>TiO<sub>4</sub>$ , the first member of the  $Sr_{n+1}Ti_nO_{3n+1}$  Ruddlesden-Popper series, within density-functional theory. Motivated by recent work in which thin films of  $Sr_2TiO_4$  were grown by molecular beam epitaxy on  $SrTiO_3$  substrates, the in-plane lattice parameter was fixed to the theoretically optimized lattice constant of cubic SrTiO<sub>3</sub> ( $n=\infty$ ), while the out-ofplane lattice parameter and the internal structural parameters were relaxed. The fully relaxed structure was also investigated. Density-functional perturbation theory was used to calculate the zone-center phonon frequencies, Born effective charges, and the electronic dielectric permittivity tensor. A detailed study of the contribution of individual infrared-active modes to the static dielectric permittivity tensor was performed. The calculated Raman and infrared phonon frequencies were found to be in agreement with experiment where available. Comparisons of the calculated static dielectric permittivity with experiments on both ceramic powders and epitaxial thin films are discussed.

DOI: 10.1103/PhysRevB.68.184111 PACS number(s): 77.22.Ch, 63.20.Dj, 61.66.Fn

### **I. INTRODUCTION**

Nonstoichiometric  $SrTiO<sub>3</sub>$  resists the formation of point defects by forming crystallographic shear  $(CS)$  phases.<sup>1</sup> For excess SrO, these CS phases form the  $Sr_{n+1}Ti_nO_{3n+1}$ Ruddlesden-Popper (RP) series. The structures of the members of the RP series can be viewed as a stacking of SrOterminated SrTiO<sub>3</sub> perovskite  $[001]$  slabs with relative shifts of  $(a_0/2)$  [110], the slabs in the *n*th member of the series having a thickness of *n* cubic perovskite lattice constants. This representation of the structure for  $n=1$  is shown in Fig.  $1(a)$ .

Considerable fundamental and practical interest in the RP series arises from the dielectric properties of its end member  $SrTiO<sub>3</sub>$  ( $n=\infty$ ). Strontium titanate is an incipient ferroelectric with a high dielectric constant that can be readily tuned by applying a small dc bias.  $SrTiO<sub>3</sub>$  has low dielectric loss at microwave frequencies but a large temperature coefficient of dielectric constant (TCF). The prospect of "engineering" the properties of the constituent  $SrTiO<sub>3</sub>$  layers by varying *n* has stimulated the synthesis and study of the dielectric properties of various members of the RP series. Through the use of conventional ceramic processing techniques, single phase  $Sr_2TiO_4$  ( $n=1$ ),<sup>1–5</sup>  $Sr_3Ti_2O_7$  ( $n=2$ ),<sup>1,3–6</sup> and  $Sr_4Ti_3O_{10}$   $(n=3)$ ,<sup>3</sup> were formed. Recently, thin films of the first five members of the RP series were grown by molecularbeam epitaxy (MBE) on  $SrTiO<sub>3</sub>$  substrates.<sup>7,8</sup> Sr<sub>2</sub>TiO<sub>4</sub>,  $Sr_3Ti_2O_7$ , and  $Sr_4Ti_3O_{10}$  were found to be nearly single phase while  $Sr_5Ti_4O_{13}$  and  $Sr_6Ti_5O_{16}$  films showed noticeable antiphase boundaries and intergrowth defects.<sup>8</sup> The dielectric properties of the  $n=1, 2$ , and  $\infty$  ceramic samples have been characterized by various groups. $4,5,9,10$  The dielectric properties of the  $n=3$  and 4 ceramic samples have also been studied but these were believed not to be single phase.<sup>5</sup> It was found that  $SrTiO<sub>3</sub>$  had both the highest dielectric constant,  $\epsilon_r$ , and the largest TCF of the RP series. Conversely,  $Sr_2TiO_4$  was found to have the lowest  $\epsilon_r$  of the series but also the lowest TCF (an order of magnitude smaller than  $SrTiO<sub>3</sub>$ ) while having a dielectric loss comparable to  $SrTiO<sub>3</sub>$ . For thin films, Haeni *et al.*<sup>8</sup> performed low-frequency and microwave experiments to measure the dielectric permittivity of  $Sr_2TiO_4$  and of  $Sr_3Ti_2O_7$ , to be discussed below.

Here we take the first step in understanding the dielectric behavior of the  $Sr_{n+1}Ti_nO_{3n+1}$  Ruddlesden-Popper (RP) series from first principles by presenting our study of the structural and dielectric properties of  $Sr_2TiO<sub>4</sub>$  ( $n=1$ ) using density-functional theory (DFT) structural optimization as well as density-functional perturbation theory (DFPT). DFT and DFPT have proved to be useful tools in investigating the structure, dynamical, and dielectric properties of metals and insulators, including complex oxides (see Ref. 11 for a review). In Sec. II we give the details of our DFT/DFPT calculations and describe various constraints that we imposed on the  $Sr_2TiO<sub>4</sub>$  structure. In Sec. III the results of our calculations for the ground-state structural parameters, Born effective charges, zone-center phonons, and electronic and static dielectric permittivity tensors at  $T=0$  are presented and compared with experiment. In Sec. IV we discuss the sensitivity of the dielectric response to structural constraints and, through comparison with  $SrTiO<sub>3</sub>$ , arrive at an understanding



FIG. 1. (Color online) The structure of  $Sr<sub>2</sub>TiO<sub>4</sub>$  (space group  $I4/mmm$ ) can be viewed as  $(a)$  a stacking of SrO-terminated  $SrTiO<sub>3</sub>$  perovskite [001] slabs, (b) a stacking of TiO<sub>2</sub> and of SrO planes along  $[001]$ , and  $(c)$  a series of Ti-O chains, infinitely long in the plane along  $[100]$  and  $[010]$ , and of finite extent along  $[001]$ (the Sr atoms have been removed for clarity).

TABLE I. Wyckoff positions for  $Sr_2TiO<sub>4</sub>$ .

Atom	Wyckoff position and point symmetry	Coordinates
Ti	$(2a)$ 4/mmm	0.0.0
$O_x$ , $O_y$	$(4c)$ mmm	$\frac{1}{2}$ ,0,0; 0, $\frac{1}{2}$ ,0
$O_z$	$(4e)$ 4mm	$0,0,\pm z_{Oz}$
<b>Sr</b>	$(4e)$ 4mm	$0,0,\pm z_{sr}$

of the dielectric response and its anisotropy in the RP phases. Finally, in Sec. V we summarize our results and main conclusions.

#### **II. METHOD**

#### **A. First-principles calculations**

First-principles density-functional calculations were performed within the local-density approximation (LDA) as implemented in the ABINIT package.<sup>12,13</sup> The exchangecorrelation energy is evaluated using the Teter rational polynomial fit to the Ceperley-Alder electron-gas data.<sup>14</sup> Teter extended norm-conserving pseudopotentials were used with Ti( $3s$ , $3p$ , $4s$ , $3d$ ), Sr( $4s$ , $4p$ , $5s$ ), and O( $2s$ , $2p$ ) levels treated as valence states. The electronic wave functions were expanded in plane waves up to a kinetic energy cutoff of 35 Ha. Integrals over the Brillouin zone were approximated by sums on a  $6\times6\times2$  mesh of special *k* points.<sup>15</sup>

## **B. Structural constraints**

We first performed full optimization of the lattice parameters and internal coordinates in the reported structure of  $Sr_2TiO_4$ ,<sup>2</sup> the body-centered-tetragonal  $K_2NiF_4$  structure [space group  $I4/mmm(D_{4h}^{17})$ ], with the primitive unit cell containing one formula unit as shown in Fig. 1. Ti atoms occupy Wyckoff position  $(2a)$ ,  $O_x$  and  $O_y$  atoms  $(4c)$ , and Sr and  $O_z$  atoms (4*e*), the latter with one free parameter (displacement along  $\hat{z}$ ) each (see Table I). This yields the predicted structure under zero stress, roughly corresponding to bulk ceramic powders and relaxed epitaxial films. The structural relaxation was performed using a modified Broyden-Fletcher-Goldfarb-Shanno (BFGS) algorithm<sup>16</sup> to optimize the volume and atomic positions, followed by an optimization of the *c*/*a* ratio. This procedure was repeated to ensure convergence. The residual Hellmann-Feynman forces were less than 2 meV/Å . A second structure was considered to investigate the effects of epitaxial strain induced by the  $SrTiO<sub>3</sub>$  substrate on a fully coherent thin film. With the same space group, we fixed the in-plane lattice parameter to that of SrTiO<sub>3</sub> calculated within the present theory ( $a=3.846 \text{ Å}$ ),<sup>17</sup> while optimizing the other structural parameters: the *c* lattice constant and displacements along  $[001]$ . This was followed by ionic relaxation until the residual Hellmann-Feynman forces were less than 1 meV/Å.

The next section will show that the fully optimized lattice parameters are underestimated relative to the experimental values, a common feature in LDA calculations.18 To investigate whether our calculations of the dielectric response of  $Sr<sub>2</sub>TiO<sub>4</sub>$  are sensitive to this underestimation of the volume, two additional structures were considered. First, with the same space group, we optimized all internal coordinates fixing both the *a* and *c* lattice constants to values obtained by uniformly expanding the lattice constant of the in-plane constrained structure using the measured thermal-expansion coefficient of SrTiO<sub>3</sub> (Refs. 19 and 20) ( $\alpha \approx 7 \times 10^{-6}$ /K) and a temperature increase of 300 K. We also optimized internal coordinates fixing both the *a* and *c* lattice constants to the values experimentally obtained for the thin-film sample. In both structures the ions were relaxed until the residual Hellmann-Feynman forces were less than 1 meV/Å.

### **C. Linear-response calculations**

Linear-response methods provide an efficient means for computing quantities that can be expressed as derivatives of the total energy *E* with respect to a perturbation, such as that produced by displacement  $u_{i\alpha}$  of an atom or a homogeneous electric field  $\mathcal E$ . Examples computed in this work include the force-constant matrix elements

$$
\left.\frac{\partial^2 E}{\partial u_{i\alpha}\partial u_{j\beta}}\right|_0,
$$

where  $u_{i\alpha}$  is the displacement of atom *i* in Cartesian direction  $\alpha$  from its position in the equilibrium crystal structure, the Born effective charge tensor

$$
Z_{i\alpha\beta}^* = -\frac{\partial^2 E}{\partial d_{i\alpha}\partial \mathcal{E}_\beta},
$$

where  $d_{i\alpha}$  is the uniform displacement of the atomic sublattice *i* in Cartesian direction  $\alpha$  from its position in the equilibrium unit cell, with derivatives taken in zero macroscopic field, and the electronic susceptibility tensor

$$
\chi_{\alpha\beta} = -\frac{1}{V} \frac{\partial^2 E}{\partial \mathcal{E}_{\alpha} \partial \mathcal{E}_{\beta}},
$$

which is related to the electronic dielectric permittivity tensor  $\epsilon_{\infty}$  by  $\epsilon_{\infty}$  = 1 + 4  $\pi \chi$ , where *V* is the volume of the primitive unit cell. In this work, we compute these derivatives using the variational formulation of density-functional perturbation theory (DFPT), implemented in the ABINIT package.<sup>13,21,22</sup>

The static dielectric permittivity tensor  $\epsilon_0$  can be obtained directly from the quantities computed by DFPT. In general, the static dielectric permittivity tensor of a nonpolar material can be written<sup>23,24</sup> as the sum of the electronic dielectric permittivity tensor  $\epsilon_{\infty}$  and a sum of contributions  $\Delta \epsilon_{m}$  from each of the zone-center polar modes *m*:

$$
\epsilon_{\alpha\beta}^0 = \epsilon_{\alpha\beta}^{\infty} + \sum_m \Delta \epsilon_{m,\alpha\beta}, \qquad (1)
$$

where  $\Delta \epsilon_m$  is given by<sup>25,26</sup>

$$
\Delta \epsilon_{m,\alpha\beta} = \frac{4\pi e^2}{M_0 V} \frac{\tilde{Z}_{m\alpha}^* \tilde{Z}_{m\beta}^*}{\omega_m^2}
$$
 (2)

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TABLE II. Structural parameters of  $Sr_2TiO<sub>4</sub>$ . (a) Fully relaxed cell. (b) Relaxation along the *c* axis, with *a* lattice constant fixed at theoretical SrTiO<sub>3</sub>. (c) Relaxation with lattice constants fixed at values corrected for thermal expansion. (d) Lattice constants fixed at experimental  $(Ref. 7)$ . Lattice constants, bond lengths, and internal parameters are in  $\AA$ .

	Experimental					Present theory		Previous theory		
	Ceramic <sup>a</sup>	Ceramic <sup>b</sup>	Thin film <sup>c</sup>	(a)	(b)	(c)	(d)	Ref. $51d$	Ref. $34e$	Ref. $52^t$
Lattice constants										
$\boldsymbol{a}$	3.88	3.88	3.88	3.822	3.846	3.855	3.88	3.942	4.0	3.892
$\mathcal{C}_{\mathcal{C}}$	12.60		12.46	12.32	12.27	12.30	12.46	12.56	12.68	12.70
c/a	3.247		3.211	3.223	3.190	3.190	3.211	3.186	3.17	3.263
Bond lengths										
$Ti-O_x$		1.94		1.911	1.923	1.928	1.940		2.0	
$Ti-Oz$		1.92		1.967	1.960	1.962	1.974		2.0	
$Sr-Oz$		2.56		2.402	2.397	2.406	2.455		2.47	
Internal parameters										
$\delta_{\textrm{SrO}}$				0.176	0.182	0.180	0.173		0.12	
$u^{\,\prime}$				1.879	1.869	1.872	1.888		1.94	
v				2.402	2.397	2.406	2.455		2.47	
Reduced coordinates										
$z_{Oz}$				0.160	0.160	0.160	0.158		0.158	
$z_{Sr}$				0.355	0.355	0.355	0.355		0.353	

a References 1–4.

<sup>b</sup>Reference 35.

<sup>c</sup>Reference 7.

d *Ab initio*, DFT, GGA.

e Semiempirical Hartree-Fock.

f Empirical atomistic simulations.

Here,  $M_0$  is a reference mass taken as 1 amu.  $(4\pi e^2/M_0V)\tilde{Z}^*_{m\alpha}\tilde{Z}^*_{m\beta}$  can be thought of as an effective plasma frequency,  $\Omega_{p,m}^2$ , of the *m*th normal mode,<sup>27,28</sup> while  $\omega_m$  is the frequency of vibration of normal mode *m*.  $\tilde{Z}_{m\alpha}^*$ , which has been referred to as a mode effective charge,  $29-31$  is given by

$$
\widetilde{Z}_{m\alpha}^{*} = \sum_{i\gamma} Z_{\alpha\gamma}^{*}(i) \left(\frac{M_0}{M_i}\right)^{1/2} \xi_m(i\gamma), \tag{3}
$$

where  $\xi_m$  is the dynamical matrix eigenvector; the corresponding real space eigendisplacement of atom  $i$  along  $\beta$  is given by  $U_m(i\beta) = \xi_m(i\beta)/M_i^{1/2}$ .<sup>32</sup> Thus we see that large lattice contributions to the static dielectric permittivity tensor are expected if the relevant mode frequencies are very low and/or if the effective plasma frequencies are large (reflecting large mode effective charges).

This formalism has been applied in a first-principles context in numerous calculations of the zero-temperature static dielectric response (for a review, see Ref. 33) in simple and complex oxides. For example, recent calculations for zircon  $(ZrSiO<sub>4</sub>)$  (Ref. 23) and zirconia (ZrO<sub>2</sub>) (Refs. 24 and 29) yield good agreement with experiment.

## **III. RESULTS**

# **A. Crystal structure of Sr2TiO4**

The reported crystal structure of  $Sr<sub>2</sub>TiO<sub>4</sub>$  can also be viewed as a stacking of TiO<sub>2</sub> and SrO planes along  $[001]$  as shown in Fig.  $1(b)$ , the stacking sequence being  $TiO<sub>2</sub>-SrO-SrO$  where the second SrO layer is shifted with respect to the previous SrO layer by  $\frac{1}{2}a_0$  along [110]. In previous work, $34$  the internal structural parameters are presented as  $u'$  and  $v$ , the distance between TiO<sub>2</sub> and SrO planes and between successive SrO planes, respectively, and  $\delta$ , the distance along *c* between Sr and O in the same SrO layer, which quantifies the ''rumpling'' of the layer.

In Table II we present the theoretical lattice parameters for the structures discussed in Sec. II and compare them with the experimental values for ceramic samples<sup>2, $\tilde{4}$ ,35 and for thin</sup> films epitaxially grown on  $SrTiO<sub>3</sub>$  ( $a=3.905$  Å) substrates.<sup>7,8</sup> The lattice constants of the fully relaxed structure, Table II, column  $(a)$ , are smaller than the measured lattice constants of the ceramic powder. Specifically, the *a* lattice parameter was calculated to be less than experiment by 1.5%, which is within the error typically associated with the LDA, while the *c* lattice parameter is underestimated by 2.2%. The smaller value of *c* measured for the thin-film samples reduces this discrepancy to 1.1%. There is considerable rumpling of the SrO layers,  $\delta_{SrO} = 0.05a_0$ . This rumpling is such that the O*<sup>z</sup>* and Sr atoms move in a direction away from and towards the  $TiO<sub>2</sub>$  layers, resulting in a  $Ti-O<sub>7</sub>$ bond slightly larger  $(2.9%)$  than the Ti-O<sub>y</sub> (or equivalently Ti-O*x*) bond. As pointed out by Noguera, Ruddlesden and Popper had assumed that this rumpling was equal to zero. The present study supports the previous calculation<sup>34</sup> by finding a nonzero rumpling. The experimental work of Venkateswaran *et al.*<sup>35</sup> also suggested a nonzero rumpling of the

		(a)			(b)			(c)			(d)	
Atom		$Z_{xx}^*$ $Z_{yy}^*$	$Z_{zz}^*$		$Z_{xx}^*$ $Z_{yy}^*$	$Z_{zz}^*$	$Z_{xx}^*$	$Z_{vv}^*$	$Z_{77}^*$	$Z^*_{xx}$	$Z_{vv}^*$	$Z_{zz}^*$
Ti	6.96	6.96	5.14	6.89	6.89	5.20	6.88	6.88	5.20	6.88	6.88	5.15
$O_v$		$-2.04$ $-5.46$ $-1.56$			$-2.05$ $-5.40$ $-1.55$			$-2.04$ $-5.40$ $-1.55$			$-2.04$ $-5.42$ $-1.52$	
<b>Sr</b>		2.37 2.37	2.75		2.36 2.36	2.76	2.36	2.36	2.75	2.37	2.37	2.72
$\mathbf{O}_{\tau}$		$-2.09$ $-2.09$ $-3.74$			$-2.08$ $-2.08$ $-3.79$			$-2.07$ $-2.07$ $-3.78$			$-2.08 - 2.08$	$-3.75$

TABLE III. Nonzero components of the calculated Born effective charge tensors  $Sr<sub>2</sub>TiO<sub>4</sub>$ .

SrO layer ( $\delta_{SrO}$ =0.10),<sup>36</sup> but found that the Ti-O<sub>z</sub> bond is shorter than the Ti-O*<sup>y</sup>* bond.

Next, we consider the structure in which we constrained the in-plane lattice constant to that of theoretical  $SrTiO<sub>3</sub>$  (*a*  $=$  3.846 Å), Table II column (b). This places the system under tensile in-plane stress equal to that of an experimental sample of  $Sr<sub>2</sub>TiO<sub>4</sub>$  coherently matched to  $SrTiO<sub>3</sub>$  (lattice mismatch 0.6%). As can be seen in Table II, this has almost no effect on the optimized values of the other structural parameters, including *c*.

Finally, we consider the optimized structural parameters for the two expanded structures. The slight thermal expansion of the in-plane constrained structure has a correspondingly slight effect on the internal parameters, while the expanded *c* of the experimental thin-film structure has a larger effect. We see that a roughly homogeneous expansion of the lattice, i.e., column (a)→(d) and (b)→(c), decreases the rumpling of the SrO layer.

### **B. Born effective charge tensors**

In the  $Sr<sub>2</sub>TiO<sub>4</sub>$  structure, the site symmetries of the Ti atom, occupying Wyckoff position 2*a*, and the O*<sup>z</sup>* and Sr atoms, both occupying Wyckoff position 4*e*, are tetragonal, while that of the  $O_x$  and  $O_y$  atoms, Wyckoff position 4*c*, is orthorhombic. As a result, all *Z*\*'s are diagonal with two  $[Z^*(T_i), Z^*(O_7), \text{ and } Z^*(S_r)]$  and three  $[Z^*(O_7), \text{ and } Z^*(S_r)]$  $Z^*(O_r)$ ] independent components. Table III displays the diagonal components of the calculated Born effective charge tensors in  $Sr<sub>2</sub>TiO<sub>4</sub>$  for the four structures considered. We see that the *Z*\*'s are relatively insensitive to the various volume and strain constraints imposed, consistent with what was shown for isotropic volume changes in BaTiO<sub>3</sub>,<sup>37</sup> and for pure tetragonal strain in  $KNbO_3$ .<sup>38</sup> Also, we note an anomalously large value for  $Z_{xx}^*(\text{Ti}) = Z_{yy}^*(\text{Ti})$  (nominal charge +4) and for  $Z_{xx}^*(O_x) = Z_{yy}^*(O_y)$  (nominal charge -2), these being the components of the *Z*\*'s corresponding to motion parallel to the Ti-O bond along a direction in which the infinite Ti-O chains have been preserved. In contrast, the anomalous parts of  $Z_{zz}^*(T_i)$  and  $Z_{zz}^*(O_z)$ , which again correspond to motion parallel to the Ti-O bond, but along  $[001]$ where the Ti-O bonds do not form continuous chains, are found to be less than half of those along the continuous Ti-O chain.

### **C. Phonon frequencies at**  $\Gamma$

For the  $Sr<sub>2</sub>TiO<sub>4</sub>$  structure, group-theoretical analysis predicts that the 18 zone-center optic modes transform according to the following irreducible representations:

$$
\Gamma_{optic} = 2A_{1g} \oplus 2E_g \oplus 3A_{2u} \oplus 4E_u \oplus B_{2u},\tag{4}
$$

of which the  $A_{1g}$  and  $E_g$  modes are Raman active, the  $A_{2u}$ and  $E_u$  modes are infrared active, and the  $B_{2u}$  mode is neither Raman nor infrared active. By using projection operator methods, it can be shown that the  $A_{1g}$ ,  $A_{2u}$ , and  $B_{2u}$  modes involve motion along  $[001]$  while in the  $E<sub>g</sub>$  and  $E<sub>u</sub>$  modes, atoms move along  $[100]$  and  $[010]$ . A complete listing of the symmetry adapted lattice functions is given in Refs. 39 and 40.

Table IV displays our calculated frequencies and mode assignments for the four structures considered. Comparing the calculated phonon frequencies for the fully relaxed structure  $\lceil \text{column (a)} \rceil$  with those measured by Burns *et al.* on ceramic samples,<sup>39</sup> also given in Table IV, we find excellent agreement. The calculations allow us to confirm the mode assignments of the  $A_{2u}(\text{TO1})$  and  $E_u(\text{TO3})$ : Burns' suggestion of assigning the lower mode at  $242$ -cm<sup>-1</sup>  $A_{2u}$  symmetry and the higher mode at  $259 \text{-cm}^{-1}$   $E_u$  symmetry appears to

TABLE IV. Phonon frequencies  $(cm<sup>-1</sup>)$  and mode assignments for  $Sr_2TiO<sub>4</sub>$ . Symmetry labels follow the convention of Ref. 53. Experimental values are from Ref. 39.

Mode	Expt.	(a)	(b)	(c)	(d)
Raman					
$A_{1g}$	205	216	217	214	200
$A_{1g}$	578	588	594	588	562
$E_{g}$	124	121	118	115	106
$E_{g}$	286	271	268	266	263
Infrared					
$A_{2u}$ (TO1)	242	231	231	227	206
$A_{2u}$ (TO2)		378	391	389	368
$A_{2u}$ (TO3)	545	499	501	496	478
$A_{2u}$ (LO)		252	253	249	233
$A_{2u}$ (LO)	467	479	482	480	472
$A_{2u}$ (LO)	683	684	692	687	658
$E_u$ (TO1)	151	148	134	129	117
$E_u$ (TO2)	197	218	211	208	198
$E_u$ (TO3)	259	246	247	244	230
$E_u$ (TO4)		611	590	581	554
$E_u$ (LO)	182	184	180	177	168
$E_u$ (LO)	239	227	225	223	216
$E_u$ (LO)	467	451	450	448	443
$E_u$ (LO)	727	789	766	756	727
Silent					
$B_{2u}$		303	310	310	303

TABLE V. Dynamical matrix eigenvectors  $\xi_m$  of  $Sr_2TiO_4$  for the fully relaxed structure with *a*  $=$  3.822 Å and  $c=12.32$  Å . The corresponding eigendisplacement in real space can be obtained by dividing each value by the appropriate mass factor  $\sqrt{M_i}$ . Modes  $A_{1g}$ ,  $A_{2u}$ , and  $B_{2u}$  involve motion along [001], while the twofold degenerate modes  $E_g$  and  $E_u$  involve motion along [100] and equivalently along [010].

					Eigenmodes			
Mode	Frequency	Ti	$O_v$	$O_x$	Sr(1)	Sr(2)	$O_{7}(1)$	$O_z(2)$
Raman								
$A_{1g}$	216	$\theta$	$\theta$	$\mathbf{0}$	$-0.71$	0.71	0.03	$-0.03$
$A_{1g}$	588	$\overline{0}$	$\theta$	$\mathbf{0}$	$-0.03$	0.03	$-0.71$	0.71
$E_{g}$	121	$\overline{0}$	$\theta$	$\mathbf{0}$	$-0.70$	0.70	$-0.06$	0.06
$E_{g}$	271	$\overline{0}$	$\overline{0}$	$\mathbf{0}$	0.06	$-0.06$	$-0.70$	0.70
Infrared								
$A_{2u}$ (TO1)	231	0.48	0.38	0.38	$-0.44$	$-0.44$	0.23	0.23
$A_{2u}$ (TO2)	378	$-0.77$	0.29	0.29	0.01	0.01	0.34	0.34
$A_{2u}$ (TO3)	499	0.11	$-0.46$	$-0.46$	$-0.07$	$-0.07$	0.53	0.53
$E_u$ (TO1)	148	0.14	0.11	0.24	$-0.37$	$-0.37$	0.56	0.56
$E_u$ (TO2)	218	$-0.77$	$-0.29$	$-0.14$	0.24	0.24	0.31	0.31
$E_u$ (TO3)	246	0.45	$-0.86$	$-0.19$	0.02	0.02	0.09	0.09
$E_u$ (TO4)	611	0.16	0.32	$-0.91$	0.00	0.00	0.14	0.14
Silent								
$B_{2u}$	303	$\overline{0}$	0.71	$-0.71$	$\overline{0}$	$\theta$	$\mathbf{0}$	$\Omega$

be correct. In addition, Burns' assessment that the strong LO feature at  $\approx$  440 cm<sup>-1</sup> in the measured reflectivity spectra was "probably" due to both a  $A_{2u}(LO)$  and a  $E_u(LO)$  mode is consistent with our calculations, where we found  $A_{2u}(\text{LO}) = 479 \text{ cm}^{-1}$  and  $E_u(\text{LO}) = 451 \text{ cm}^{-1}$ .<sup>41</sup> In fact, an average of these two frequencies is within 2  $cm^{-1}$  of the quoted value  $467 \text{ cm}^{-1}$ . Finally, we obtain the frequencies of four modes that could not be separately identified in the experiment, namely the  $A_{2u}(\text{TO2})$  mode at 378 cm<sup>-1</sup>, the  $A_{2u}$ (LO) mode at 252 cm<sup>-1</sup>, the  $E_u$ (TO4) mode at 611 cm<sup>-1</sup>, and the  $B_{2u}$  mode at 303 cm<sup>-1</sup>.

In Table V we give the normalized dynamical matrix eigenvectors for the fully relaxed structure  $(a)$ . We see that the lowest frequency  $A_{2u}(\text{TO1})$  and  $E_u(\text{TO1})$  modes involve Sr atoms moving against a fairly rigid  $TiO<sub>6</sub>$  octahedron, with larger deformation of the octahedron for the  $E_u$  mode. The highest frequency  $A_{2u}(\text{TO3})$  and  $E_u(\text{TO4})$  modes each involve large distortions of the oxygen octahedra with the apical oxygens moving against the planar oxygens in the  $A_{2u}$ mode and a corresponding distortion for the *Eu* mode. The calculated  $A_{2u}(\text{TO2})$  mode involves Ti atoms moving against a nearly rigid oxygen octahedron, giving rise to a relatively large mode effective charge. Finally, the  $E_u(TO2)$ mode, characterized by Burns *et al.* as a weak infrared active mode, has displacements of O<sub>y</sub> and O<sub>z</sub> very close to those of the triply degenerate silent mode in the cubic perovskite. These patterns are substantially different from those obtained in model calculations of the lattice dynamics of  $K_2ZnF_4$ ,<sup>42</sup> used by Burns to characterize the eigenvectors of  $Sr<sub>2</sub>TiO<sub>4</sub>$ , especially for the highest frequency  $A_{2u}(\text{TO3})$  and  $E_u(\text{TO4})$ modes and the  $A_{2u}(\text{TO2})$  mode.

The effective plasma frequencies (Sec. II C) are reported in Table VI. There is relatively little variation among the different modes of the same symmetry in the same structure, with  $\Omega_{p,m} \approx 400$  and 800 cm<sup>-1</sup> for the  $A_{2u}$  and  $E_u$ , respectively, and even less variation with changes in the structure. The largest calculated effective plasma frequency is obtained for the  $A_{2u}(\text{TO2})$  mode. While the corresponding oscillator strength, which goes like  $\Omega_{p,m}^2$ , should make this the most prominent mode in a single-crystal infrared study, it was not

TABLE VI. Effective plasma frequency  $\Omega_{p,m}$  (cm<sup>-1</sup>) and mode contribution to the static dielectric tensor  $\Delta \epsilon_m$  in Sr<sub>2</sub>TiO<sub>4</sub>.

	(a)			(b)			(c)			(d)	
$\omega_m$	$\Omega_{p,m}$	$\Delta \epsilon_m$	$\omega_m$		$\Delta \epsilon_m$	$\omega_m$		$\Delta \epsilon_m$	$\omega_m$	$\Omega_{p,m}$	$\Delta \epsilon_m$
231	457	3.93	231	446	3.71	227	449	3.93	206	474	5.28
378	1061	7.86	391	1066	7.42	389	1073	7.62	368	1083	8.66
499	427	0.73	501	447	0.80	496	409	0.68	478	232	0.24
148	752	25.9	134	809	36.4	129	829	41.0	117	888	57.24
218	473	4.69	211	491	5.41	208	507	5.95	198	586	8.80
246	794	10.4	247	745	9.08	244	723	8.78	230	617	7.21
611	812	1.77	590	759	1.65	581	737	1.61	554	674	1.48
					$\Omega_{p,m}$			$\Omega_{p,m}$			

TABLE VII. Nonzero components of the electronic and the ionic dielectric tensors for  $Sr_2TiO_4$  ( $\epsilon_{11}$ , $\epsilon_{22}$ , $\epsilon_{33}$ ). Experimental measurements on thin films (Ref. 8) and on ceramic samples (Refs. 4, 5 and 9) were conducted at room temperature except for  $\dagger$  (*T* = 15 K).

			Experimental					
	Ref. 8	Ref. 9	Ref. 4	Ref. 5	(a)	(b)	(c)	(d)
$\epsilon_{\infty}$					(5.09, 5.09, 4.81)	(5.08, 5.08, 4.82)	(5.07, 5.07, 4.82)	(5.08, 5.08, 4.79)
$\epsilon_{ionic}$					(42.8, 42.8, 12.5)	(52.6, 52.6, 11.9)	(57.3, 57.3, 12.2)	(74.7, 74.7, 14.2)
$\epsilon_0$					(48, 48, 17)	(58, 58, 17)	(62, 62, 17)	(80, 80, 19)
$\epsilon_{average}$	$44 \pm 4$	38	$34.37^{\dagger}$	37	38	44	47	60

separately identified in the ceramic sample of Burns. In ceramics, while the reststrahlen bands do not overlap for modes transforming as the same irreducible representation, the  $A_{2u}$  modes can overlap the  $E_u$  and vice versa. In fact, we see that not only the  $A_{2u}(TO2)$  mode, but also a second high-oscillator strength mode,  $E_u(TO4)$ , not identified in the measurements of Burns, lie in the middle of a wide reststrahlen band of the other symmetry type. As noted by Burns, this would undoubtedly complicate the interpretation of the reflectivity spectrum and may explain why neither of these modes were identified.

#### **D. Dielectric permittivity tensors**

Here we present our calculation of the static dielectric permittivity tensor  $\epsilon_0$  for the structures considered in Table II. By the symmetry of the  $Sr<sub>2</sub>TiO<sub>4</sub>$  structure we see that the tensors are diagonal and have two independent components, along directions parallel to and perpendicular to the  $TiO<sub>2</sub>$ layers. In Table VII we display the results of our calculations for these three tensors ( $\epsilon_{\infty}$ ,  $\epsilon_{ionic}$ , and  $\epsilon_{0}$ ) for Sr<sub>2</sub>TiO<sub>4</sub> under the various structural constraints previously discussed  $($ see the caption of Table II $)$ . It can be seen that the static dielectric permittivity tensor is quite anisotropic, with the in-plane components nearly three times as large as the component along  $[001]$ .

To improve our understanding of this anisotropy we examine the contribution to  $\epsilon_{ionic}$  from individual phonon modes. In Table VI we show the effective plasma frequency  $\Omega_{p,m}$  and the contribution to the static dielectric permittivity for each IR-active phonon mode, equal to  $\Omega_{p,m}^2/\omega_m^2$ . The  $A_{2u}$  and the  $E_u$  modes contribute to the components of  $\epsilon_0$ along directions perpendicular and parallel to the  $TiO<sub>2</sub>$  layers, respectively. We see that the dominant mode contributing to the rather large anisotropy is the  $E_u(T01)$  mode, while the largest  $\Omega_{p,m}$  is associated with the  $A_{2u}(\text{TO2})$ mode. In fact, the effective plasma frequency of the  $A_{2u}(\text{TO2})$  mode is  $\sim$  40% larger than that of the  $E_u(\text{TO1})$ mode. The fact that the frequency of this  $A_{2u}(\text{TO2})$  mode is more than twice that of the soft  $E_u(\text{TO1})$  mode explains its relatively small contribution to the dielectric permittivity tensor.

Finally, to compare the calculated dielectric permittivity tensors with the measured dielectric constant of the ceramic samples  $\epsilon_r$ , we compute an orientational average  $\epsilon_{average}$  of our calculated results. From Table VII we see that  $\epsilon_{average}$  $=$  38 for the fully relaxed structure agrees quite well with  $\epsilon_r$ =34–38 measured by the various groups. The comparison with the thin-film results is more problematic and will be discussed in the next section.

## **IV. DISCUSSION**

In this section, we discuss the main features of the  $T=0$ dielectric response of  $Sr<sub>2</sub>TiO<sub>4</sub>$ . We show that the anisotropy and sensitivity to changes in the lattice constants through epitaxial strain and thermal expansion can be understood by relating the dielectric response of  $Sr_2TiO_4$  to that of  $SrTiO_3$ . Finally, we discuss the comparison of the results of our calculations to available experimental data.

First, we consider the Born effective charges. In  $SrTiO<sub>3</sub>$ , the anomolously large Born effective charges for Ti and O (Table VIII) can be directly linked to the presence of infinite Ti-O chains running in all three Cartesian directions. 43,44 In  $Sr<sub>2</sub>TiO<sub>4</sub>$  the infinite Ti-O chains lying in the TiO<sub>2</sub> planes are preserved, while the Ti-O chains along  $[001]$  are broken into short O-Ti-O segments by the relative shift of the SrOterminated perovskite slabs [see Fig.  $1(c)$ ]. Correspondingly, as can be seen in Table III, the  $Z^*$ 's in  $Sr_2TiO_4$  for Ti and O displacing along the infinite chains in the  $TiO<sub>2</sub>$  layers,  $Z_{yy}^*(\text{Ti})[Z_{xx}^*(\text{Ti})]$  and  $Z_{yy}^*(O_y)[Z_{xx}^*(O_x)]$ , are only slightly smaller than those of  $SrriO<sub>3</sub>$ .<sup>45</sup> In contrast, the breaking of the Ti-O chains into O-Ti-O segments along  $[001]$  has a dramatic effect on the anomalous component of the Ti and O Born effective charges for motion along the segment,  $Z_{zz}^*(\text{Ti})$ and  $Z_{zz}^*(O_z)$ , reducing them by over a factor of 2. While it is

TABLE VIII. The structural and dielectric properties of  $SrTiO<sub>3</sub>$ calculated within present theory ( $6\times6\times6$  grid, 45 Hartree).

Lattice constant	phonons $\text{cm}^{-1}$ )	$\omega_m$	$\Delta \epsilon_m$	$\Omega_{p,m}$
$a = 3.846$ Å	$T_{1u}(\text{TO1})$	103	1275	153
Born effective charge	$T_{1u}(\text{TO2})$	189	827	19.2
$Z^*(T_i) = 7.26$	$T_{1u}(\text{TO3})$	587	946	2.6
$Z^*(Sr) = 2.55$	$T_{1u}$ (LO1)	166		
$Z^*(O_1) = -2.04$	$T_{1u}$ (LO2)	451		
$Z^*(O_{\parallel}) = -5.72$	$T_{1u}$ (LO3)	822		
Dielectric constant				
$\epsilon^{\infty}$ = 6.2, $\epsilon_0$ = 181				
Phonon eigenvector	$\{\xi_{Ti},\,\xi_{Sr},\,\xi_{O\parallel},\,\xi_{O\perp},\,\xi_{O\perp}\}\,$			
$T_{1u}(\text{TO1})$	$\{-0.14, -0.51, 0.37, 0.54, 0.54\}$			
$T_{1u}(\text{TO2})$	${0.84,-0.51,-0.02-0.12,-0.12}$			
$T_{1u} (TO3)$	$\{0.10, 0.02, -0.88, 0.33, 0.33\}$			

true that the local anisotropy caused by the somewhat larger Ti-O*<sup>z</sup>* bond length compared with the Ti-O*<sup>y</sup>* bond length will also reduce the corresponding Born effective charges, this is a much weaker effect, as suggested by the following calculation. We fixed the Ti-O*<sup>z</sup>* distance to that of the Ti-O*<sup>y</sup>* bond length of structure  $(b)$  (where the in-plane plane lattice parameter was fixed to the lattice constant of  $SrTiO<sub>3</sub>$ ), creating a structure whereby the Ti-O distances are equal in all three cartesian directions. The Born effective charges along  $[001]$ were found to increase compared with those of Table III $(b)$ , but only slightly  $[Z_{zz}^*(T_i) = 5.29$  and  $Z_{zz}^*(O_z) = -3.80$ .

This reduction of the anomalous component of the Born effective charges is quite similar to the reduction of the *Z*\*'s observed in BaTiO<sub>3</sub> due to the ferroelectric transition. Indeed, Ghosez *et al.*<sup>37,46</sup> found that  $Z^*(\text{Ti})=7.29$  and  $Z^*(O_{\parallel}) = -5.75$  in cubic BaTiO<sub>3</sub> while in the tetragonal phase they found  $Z_{yy}^*(\text{Ti})=6.94$ ,  $Z_{yy}^*(\text{O}_y)=-5.53$ ,  $Z_{zz}^*(\text{Ti})$ = 5.81, and  $Z_{zz}^{*}(O_{z}) = -4.73$ . It was explained that this reduction of the *Z*\*'s going from the cubic to the tetragonal phase resulted from the displacement of the Ti atom along the ferroelectric axis, resulting in a series of long-short Ti-O bonds thereby "breaking" the Ti-O chains.<sup>46</sup> In  $Sr_2TiO_4$  this breaking of the Ti-O chains can be thought of as being caused not by alternating Ti-O bond lengths along a given direction, but by the shift of the SrO-terminated  $SrTiO<sub>3</sub>$ slabs, resulting in a SrO-SrO antiphase boundary perpendicular to  $[001]$  as discussed in Sec. III A. Finally, this breaking of the chains in  $Sr_2TiO_4$  is arguably a much "stronger" effect than the cubic-to-tetragonal transition in BaTiO<sub>3</sub>, as evidenced by the greater reduction of the Born effective charges along  $[001]$ .

We now consider the frequencies and eigenvectors of the infrared active modes of the dynamical matrix. In Table VI, it can be seen that the large in-plane response in  $Sr<sub>2</sub>TiO<sub>4</sub>$  is dominated by the  $E_u(TO1)$  mode. This mode has displacements in the SrO-terminated perovskite slab, so that the longitudinal nearest neighbors of each atom are arranged as in  $SrTiO<sub>3</sub>$ . The primary difference is in the atomic arrangements and transverse force constants between atoms in adjacent slabs. As a result, the frequency is low, though not as low as that of the  $T_{1u}(\text{TO1})$  mode in SrTiO<sub>3</sub>. The relationship of this  $E_u(TO1)$  mode in  $Sr_2TiO_4$  to the  $T_{1u}(TO1)$  mode in  $SrTiO<sub>3</sub>$  is further evidenced by its similar high sensitivity to the lattice constant.<sup>47,48</sup> With the change in *a* from 3.822 Å [case (a)] to 3.88 Å [case (d)], the mode significantly softens, leading to an increase in the in-plane component of the dielectric tensor by over a factor of two.

In contrast, the  $A_{2u}$  TO modes involve displacements out of the perovskite slab, so that the longitudinal nearest neighbor arrangements of the Sr and O*<sup>z</sup>* atoms are distinct from those in  $SrTiO<sub>3</sub>$ . As a result, these modes are much more affected than the  $E_u$  TO modes by the change in structure relative to  $SrTiO<sub>3</sub>$ . There is no mode with very low frequency, and the mode-by-mode contributions to the dielectric tensor, even that of the  $A_{2u}$  (TO2) mode with its large oscillator strength, are modest. As can be seen from Table VI, these modes are rather insensitive to the in-plane lattice constant, with a corresponding constancy in  $\epsilon_{33}$ .

These observations should generalize, at least semiquantitatively, to higher RP phases (with  $n>1$ ) of Sr-Ti-O. For instance, the anomalous contribution to the Born effective charge tensors of Ti and of O along directions parallel to the O-Ti-O segment should increase with *n*, but always be lower than those along the infinite chains. As the perovskite slabs get thicker, the ''surface'' effects on the eigenmodes due to the different enviroments of the Sr and O atoms in the outer layer should decrease. The low-frequency in-plane modes should increasingly resemble those of  $SrTiO<sub>3</sub>$ . Most significantly, the frequencies of the lowest  $A_{2u}$  modes should decrease, the result being that the overall anisotropy will decrease and reach the isotropic limit as  $n \rightarrow \infty$ . Because structural modifications to the internal parameters  $(u', v,$  and  $\delta_{SrO}$ ), in addition to changes in lattice parameters (*a* and *c*), are to be expected with structures of increasing *n*, the question of how exactly these quantities change with *n* cannot be answered without full first-principles calculations on higher RP structures.49 Similar considerations should apply for other titanate perovskite-related materials, and could be used in the theoretical design of new dielectric materials.

Anisotropy of the dielectric tensor has not been previously experimentally determined in  $Sr<sub>2</sub>TiO<sub>4</sub>$ , though measurements have been carried out for single crystals of three isostructural oxides  $CaYAIO<sub>4</sub>$ ,  $CaNdAIO<sub>4</sub>$ , and  $LaSrAIO<sub>4</sub>$ .<sup>50</sup> For all three, the anisotropy is very small (for LaSrAlO<sub>4</sub>, the out-of-plane component of the dielectric tensor,  $\epsilon_{33}$  = 20.02, is in fact slightly greater than the in-plane component  $\epsilon_{11}$  $\epsilon_{22}$ =16.81). These values are similar to that of the out-ofplane component of the dielectric tensor of  $Sr_2TiO<sub>4</sub>$ . The large anisotropy in  $Sr_2TiO<sub>4</sub>$  is thus seen to arise from the SrTiO<sub>3</sub>-related low-frequency in-plane mode, highlighting the unique physics of the mixed covalent-ionic Ti-O bonding in the titanate perovskites.

The anisotropy of the dielectric tensor is an important factor to be taken into consideration when comparing the computed dielectric response with experiment, and, indeed, in correctly interpreting experimental measurements. For ceramics, anisotropy of the single-crystal response can give a range of values for the measured dielectric response, depending on the size, shape, and interaction of the grains. In the single-crystal films, the anisotropy complicates the interpretation of the microwave microscope method of determining the dielectric response. The effective dielectric constant obtained by this technique is in fact an average of the dielectric tensor components determined by the field distribution near the probe, which is itself determined by the anisotropic dielectric response. While an exact value requires detailed modeling of the field configuration, the expectation is that the measured value should be an average weighted in favor of the high dielectric response components. Thus the value  $\epsilon_{eff}$ =44 obtained by Haeni<sup>8</sup> is not  $\epsilon_{33}$ , but is a weighted average of the three components, in accordance with our calculations. The agreement of this  $\epsilon_{eff}$  with the lowfrequency electronic measurement is apparently coincidental. The latter measurement determines  $\epsilon_{33}$ , but at low frequencies it is not unusual for additional extrinsic contributions to raise the value of the dielectric response.

# **V. SUMMARY**

We have investigated the structural and dielectric properties of  $Sr_2TiO_4$ , the first member of the  $Sr_{n+1}Ti_nO_{3n+1}$ Ruddlesden-Popper series, within density-functional theory. Density-functional perturbation theory was used to compute the zone-center phonon frequencies, Born effective charges, and the electronic dielectric permittivity tensor. The structural parameters and computed properties generally compare favorably with available experimental and previous theoretical results.

Our calculation of the static dielectric tensor of  $Sr_2TiO<sub>4</sub>$ from the above data provides valuable information about the anisotropy of the response. This anisotropy is key to interpreting the available experimental data on the dielectric response of ceramic and thin-film samples. The anisotropy in this system is seen to arise from a low-frequency in-plane mode closely related to that in  $SrTiO<sub>3</sub>$ . This picture should generalize to the higher RP phases of Sr-Ti-O as well as other titanate perovskite-related materials, and could be useful in tailoring the dielectric response of this class of materials.

## **ACKNOWLEDGMENTS**

The authors would like to acknowledge valuable discussions with Darrell Schlom, David Vanderbilt, and Morrel Cohen. This work was supported by NSF-NIRT Grant No. DMR-0103354.

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